

Search Notes

Application/Control No.

10/725,369

Examiner

Richard Chan

Applicant(s)/Patent under
Reexamination

SUGANUMA, HISASHI

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	296	6/23/2006	RC
455	266	6/23/2006	RC
455	222	6/23/2006	RC
375	104	6/23/2006	RC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
keyword: absolute adj value near4 maximum	6/23/2006	RC